

## Description

The AP22815/615 are 3A, single-channel, current-limited, high-side power switches with output overvoltage protection (OVP) optimized for USB and other hot-swap applications. The AP22815/615 comply with USB standards and are available with both polarities of Enable input. The devices also possess fixed and adjustable current-limited features optimized for applications requiring precise current-limiting support. They have USB PD3.0 fast role-swap functions, and the output voltage recovers to a valid USB voltage range within 110μs during the USB PD fast role-swap event.

The devices have fast short-circuit and output overvoltage response times for improved system robustness. Both the TSOT25 and TSOT26 packages integrate discharge circuitry inside the OUT pin. They provide a complete protection solution for applications subject to heavy capacitive loads and the prospect of short circuits, and offer output overvoltage, reverse-current, overcurrent, overtemperature, and short-circuit protection, as well as controlled rise time and undervoltage lockout functionality. A 7ms deglitch capability on the open-drain flag output prevents false overcurrent, overvoltage, and overtemperature reporting, and does not require any external components.

The AP22815 is available in a standard green TSOT25 package with RoHS compliancy. The AP22615 is available in a standard Green TSOT26 package with RoHS compliancy.

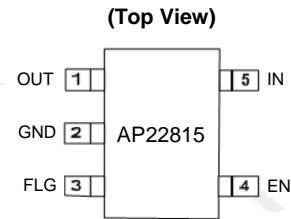
## Features

- Input Voltage Range: 3.0V to 5.5V
- 40mΩ On-Resistance
- Built-In Soft-Start with 2.1ms Typical Rise Time
- Fault Report (FLG) with Blanking Time (7ms Typ)
- Accurate Adjustable Current Limit, 0.4A to 4.0A (AP22615 Only)
- ESD Protection: 2kV HBM, 200V MM
- Active-Low or Active-High Enable
- Protection Functions:
  - Output Overvoltage with Auto Recovery
  - Overcurrent with Auto Recovery
  - Short-Circuit with Auto Recovery
  - Overtemperature with Auto Recovery
- Output Reverse Voltage/Current Protection
- Fast Role-Swap Function
- Thermally Efficient, Low-Profile Package
- UL Recognized, File Number E322375
- IEC60950-1 CB Scheme Certified
- IEC62368-1 CB Scheme Certified
- **Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. "Green" Device (Note 3)**
- **For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/104/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please [contact us](https://www.diodes.com/quality/product-definitions/) or your local Diodes representative.**

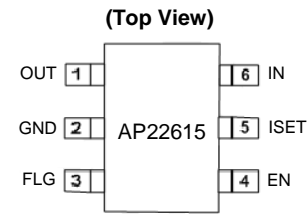
<https://www.diodes.com/quality/product-definitions/>

- Notes:
1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
  2. See <https://www.diodes.com/quality/lead-free/> for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
  3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

## Pin Assignments



TSOT25



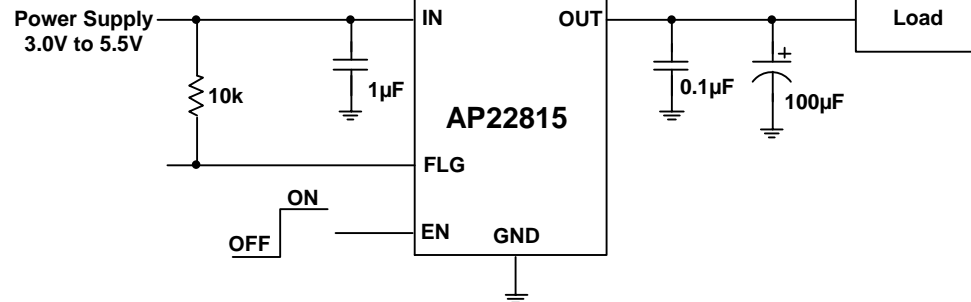
TSOT26

## Applications

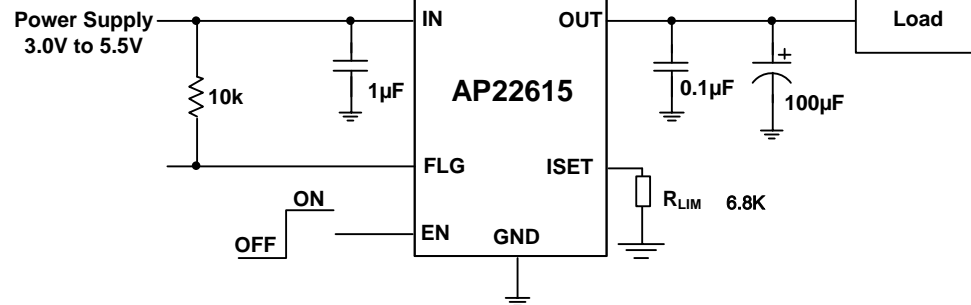
- Integrated load switches in ultrabook PCs
- Power up/down sequencing in ultrabook PCs
- Notebooks, netbook, tablet PCs, set-top boxes
- Solid state drives (SSDs)
- Consumer electronics
- USB chargers
- Telecom systems

## Typical Applications Circuit (Note 4)

### Active-High Enabled Example



### Active-High Enabled Example

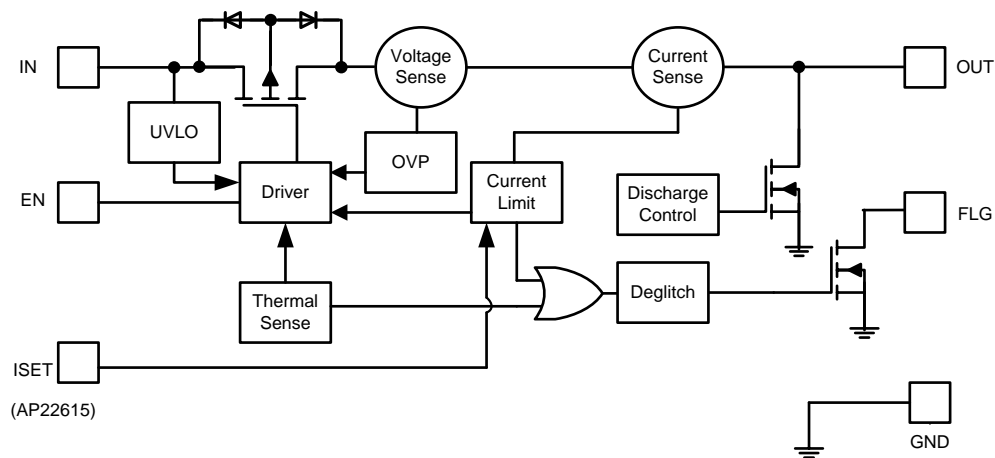


Note 4. Applying a 1μF input capacitor leads to a large  $V_{IN}$  spike, so it is recommended to use a 10μF capacitor instead.

## Pin Descriptions

AP22815	AP22615	Pin Name	Pin function
TSOT25	TSOT26		
1	1	OUT	Voltage Output Pin
2	2	GND	Ground Pin of the Circuitry
3	3	FLG	Overcurrent and Overtemperature Fault Report; Open-Drain Flag is Active Low When Triggered.
4	4	EN	Enable Input (Active Low or Active High).
NC	5	ISSET	AP22815: NC pin AP22615: Set OCP current by attaching resistor. The current limit: $I_{LIM} (A) = 6800/R_{LIM} (\Omega)$
5	6	IN	Voltage Input Pin

## Functional Block Diagram



## Absolute Maximum Ratings (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.) (Note 5)

Symbol	Parameter	Ratings	Unit
ESD HBM	Human Body ESD Protection	2000	V
ESD MM	Machine Model ESD Protection	200	V
$V_{IN}$	Input Voltage	-0.3 to 6.0	V
$V_{OUT}$	Output Voltage ( $V_{OUT}$ to GND, $V_{OUT}$ to $V_{IN}$ )	-0.3 to 28	V
$V_{EN}$	Enable Voltage	-0.3 to ( $V_{IN} + 0.3$ )	V
$V_{ISET}$	ISET Voltage	-0.3 to ( $V_{IN} + 0.3$ )	V
$I_L$	Load Current	Internal Limited	A
$T_{J(max)}$	Maximum Junction Temperature	+150	$^\circ\text{C}$
$T_{STG}$	Storage Temperature	-65 to +150	$^\circ\text{C}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 6)	TSOT25	$^\circ\text{C/W}$
		TSOT26	
$R_{\theta JC}$	Thermal Resistance, Junction to Case (Note 6)	TSOT25	$^\circ\text{C/W}$
		TSOT26	

- Note: 5. Stresses greater than the *Absolute Maximum Ratings* specified above can cause permanent damage to the device. These are stress ratings only; functional operation of the device at these or any other conditions exceeding those indicated in this specification is not implied. Device reliability can be affected by exposure to absolute maximum rating conditions for extended periods of time.
6.  $R_{\theta JA}$  and  $R_{\theta JC}$  are measured at  $T_A = +25^\circ\text{C}$  on a high effective thermal conductivity four-layer test board per JEDEC 51-7.

## Recommended Operating Conditions (Note 7)

Symbol	Parameter	Min	Max	Unit
$V_{IN}$	Input Voltage	3.0	5.5	V
$I_{OUT}$	Output Current, $4.0\text{V} \leq V_{IN} \leq 5.5\text{V}$	0	3	A
	Output Current, $3.0\text{V} \leq V_{IN} < 4.0\text{V}$	0	1.5	A
$V_{IL}$	EN Input Logic Low Voltage	0	0.4	V
$R_{LIM}$	Current-Limit Threshold Resistor Range (1% Initial Tolerance)	1.94	6.8	$\text{k}\Omega$
$V_{OUT}$	Output Voltage	0	23	V
$V_{IH}$	EN Input Logic High Voltage	1.2	$V_{IN}$	V
$T_A$	Operating Ambient Temperature	-40	+85	$^\circ\text{C}$

- Note: 7. Refer to the typical application circuit.

# Electrical Characteristics (V<sub>IN</sub> = 5.0V @ T<sub>A</sub> = +25°C, C<sub>IN</sub> = 1μF, C<sub>L</sub> = 100nF, unless otherwise specified.)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V <sub>UVLO</sub>	Input UVLO	V <sub>IN</sub> Rising	2.1	2.5	2.9	V
ΔV <sub>UVLO</sub>	Input UVLO Hysteresis	V <sub>IN</sub> Decreasing	—	180	—	mV
I <sub>SHDN</sub>	Input Shutdown Current	Disabled, OUT = Open (Discharge Current Included)	—	0.1	10	μA
I <sub>Q</sub>	Input Quiescent Current	Enabled, OUT = Open	—	300	—	μA
I <sub>LEAK</sub>	Input Leakage Current	Disabled, OUT Grounded	—	0.1	1	μA
I <sub>REV</sub>	Reverse Leakage Current	Disabled, V <sub>IN</sub> = 0V, V <sub>OUT</sub> = 5V, I <sub>REV</sub> at OUT	—	0.5	15	μA
		Disabled, V <sub>IN</sub> = 0V, V <sub>OUT</sub> = 20V, I <sub>REV</sub> at OUT	—	0.5	30	μA
R <sub>DS(ON)</sub>	Switch On-Resistance	(AP22815) V <sub>IN</sub> = 5.0V, I <sub>OUT</sub> = 1A	—	40	50	mΩ
I <sub>LIMIT</sub>	Overload Current Limit	(AP22815) V <sub>IN</sub> = 5V, V <sub>OUT</sub> = 4V	3.1	3.6	4.2	A
		(AP22615) V <sub>IN</sub> = 5V, V <sub>OUT</sub> = 4V, R <sub>LIM</sub> = 1.94kΩ	3.1	3.6	4.2	A
		(AP22615) V <sub>IN</sub> = 5V, V <sub>OUT</sub> = 4V, R <sub>LIM</sub> = 6.8kΩ	0.75	1	—	A
I <sub>SHORT</sub>	Short-Circuit Current Limit	Enabled, Output Short to Ground	—	1	—	A
t <sub>SHORT</sub>	Short-Circuit Response Time	V <sub>IN</sub> = 5V, No Load	—	5	—	μs
V <sub>IL</sub>	EN Input Logic Low Voltage	V <sub>IN</sub> = 5V	—	—	0.4	V
V <sub>IH</sub>	EN Input Logic High Voltage	V <sub>IN</sub> = 5V	1.2	—	—	V
I <sub>LEAK-EN</sub>	EN Input Leakage	V <sub>IN</sub> = 5V, V <sub>EN</sub> = 0V and 5.5V	—	1	2	μA
I <sub>LEAK-O</sub>	Output Leakage Current	Disabled, V <sub>OUT</sub> = 0V	—	0.5	1	μA
t <sub>D(ON)</sub>	Output Turn-On Delay Time	C <sub>L</sub> = 10μF, R <sub>LOAD</sub> = 10Ω @ V <sub>IN</sub> = 5V (Figure 1)	—	2.2	—	ms
t <sub>r</sub>	Output Turn-On Rise Time	C <sub>L</sub> = 10μF, R <sub>LOAD</sub> = 10Ω @ V <sub>IN</sub> = 5V (Figure 1)	1.0	1.9	3.5	ms
t <sub>D(OFF)</sub>	Output Turn-Off Delay Time	C <sub>L</sub> = 10μF, R <sub>LOAD</sub> = 10Ω @ V <sub>IN</sub> = 5V (Figure 1)	—	0.02	—	ms
t <sub>f</sub>	Output Turn-Off Fall Time	C <sub>L</sub> = 10μF, R <sub>LOAD</sub> = 10Ω @ V <sub>IN</sub> = 5V (Figure 1)	—	0.2	—	ms
R <sub>FLG</sub>	FLG Output FET On-Resistance	I <sub>FLG</sub> = 10mA	—	40	60	Ω
I <sub>FOH</sub>	FLG Off Current	V <sub>FLG</sub> = 5V	—	0.01	1	μA
t <sub>BLANK</sub>	FLG Blanking Time	Assertion or Deassertion due to Overvoltage, Overcurrent, and Overtemperature Condition	2	7	20	ms
R <sub>DIS</sub>	Discharge Resistance	V <sub>IN</sub> = 5V, Disabled, V <sub>OUT</sub> = 1V	—	100	—	Ω
T <sub>SHDN</sub>	Thermal Shutdown Threshold	Enabled	—	+140	—	°C
T <sub>HYS</sub>	Thermal Shutdown Hysteresis	—	—	+35	—	°C
V <sub>OV_TRIP</sub>	Output OVP Lockout	V <sub>OUT</sub> Rising Threshold	5.5	5.7	5.9	V
		V <sub>OUT</sub> Falling Threshold	—	5.6	—	V
OUT <sub>HYS</sub>	Output OVP Hysteresis	—	—	0.1	—	V
t <sub>OV</sub>	OVP Response Time	I <sub>OUT</sub> = 0.5A, C <sub>L</sub> = 1μF, V <sub>OUT</sub> from 5.5V to 6V	—	1	—	μs
V <sub>RVP</sub>	Reverse-Voltage Comparator Trip Point	V <sub>OUT</sub> - V <sub>IN</sub>	—	65	—	mV

## Typical Performance Characteristics

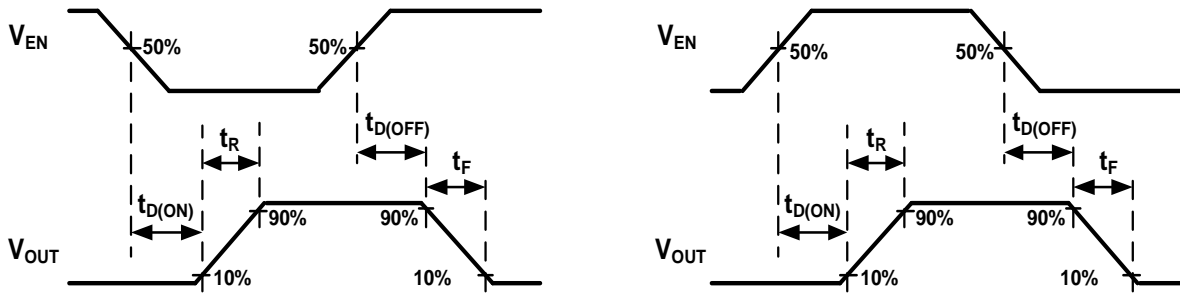
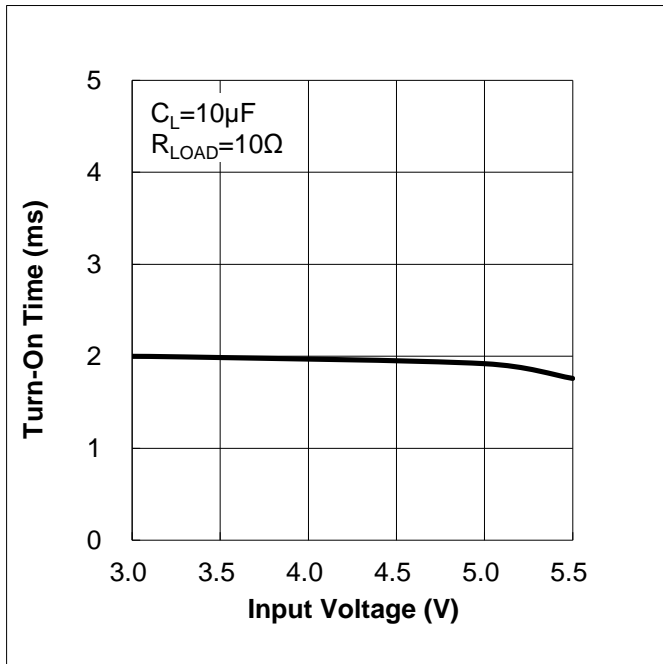


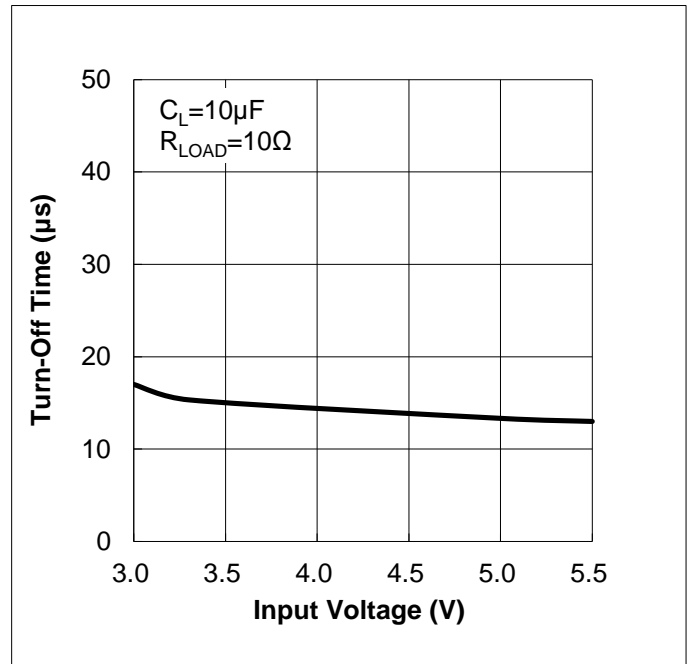
Figure 1. Voltage Waveforms

**Typical Performance Characteristics** (continued) ( $T_A = +25^\circ\text{C}$ ,  $V_{IN} = 5\text{V}$ ,  $C_{IN} = 1\mu\text{F}$ ,  $C_L = 0.1\mu\text{F}$ , unless otherwise specified.)

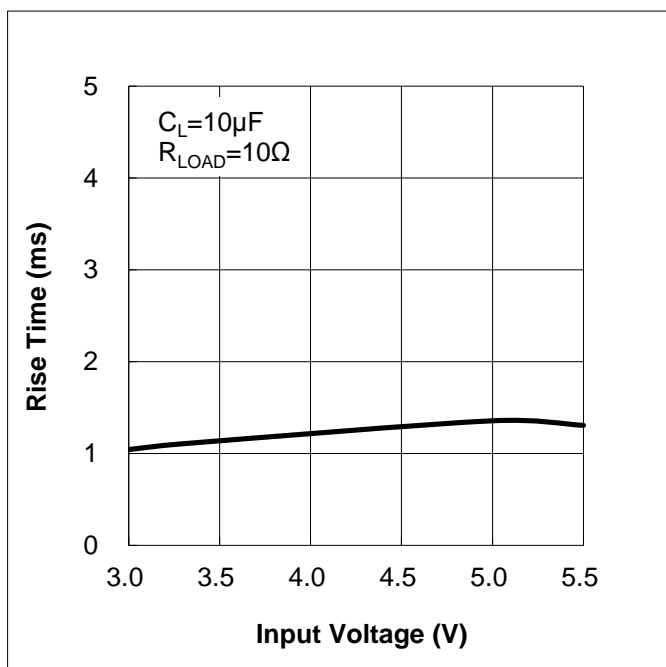
**Turn-On Time vs. Input Voltage**



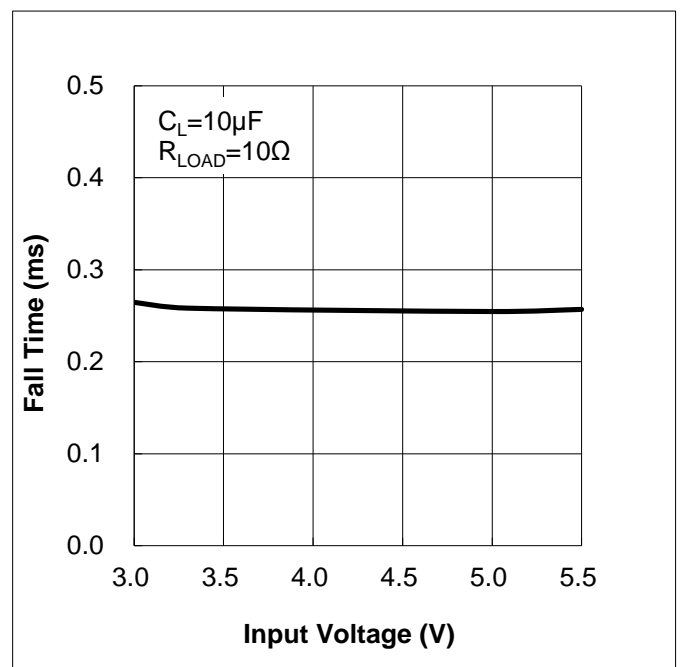
**Turn-Off Time vs. Input Voltage**



**Rise Time vs. Input Voltage**

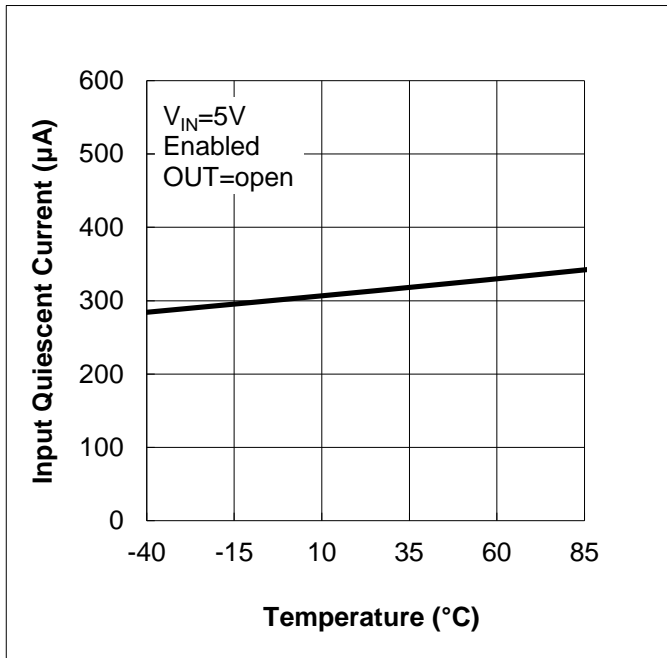


**Fall Time vs. Input Voltage**

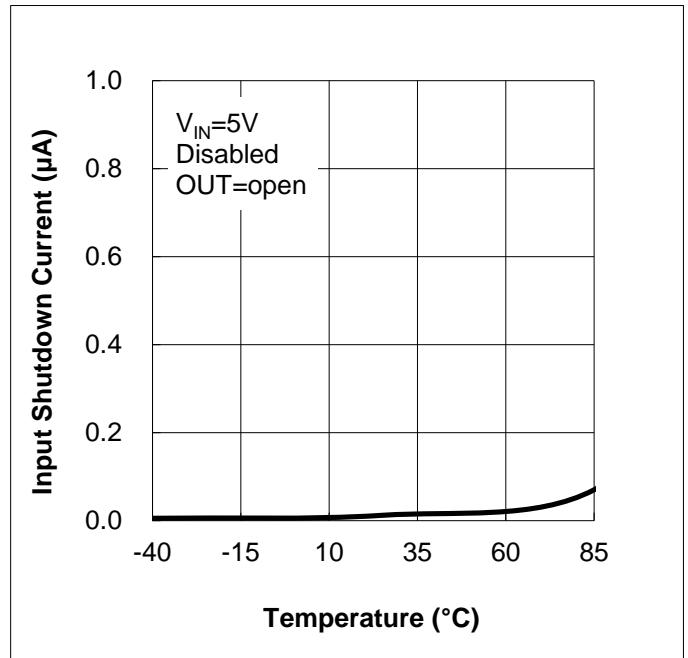


**Typical Performance Characteristics** (continued) ( $T_A = +25^\circ\text{C}$ ,  $V_{IN} = 5\text{V}$ ,  $C_{IN} = 1\mu\text{F}$ ,  $C_L = 0.1\mu\text{F}$ , unless otherwise specified.)

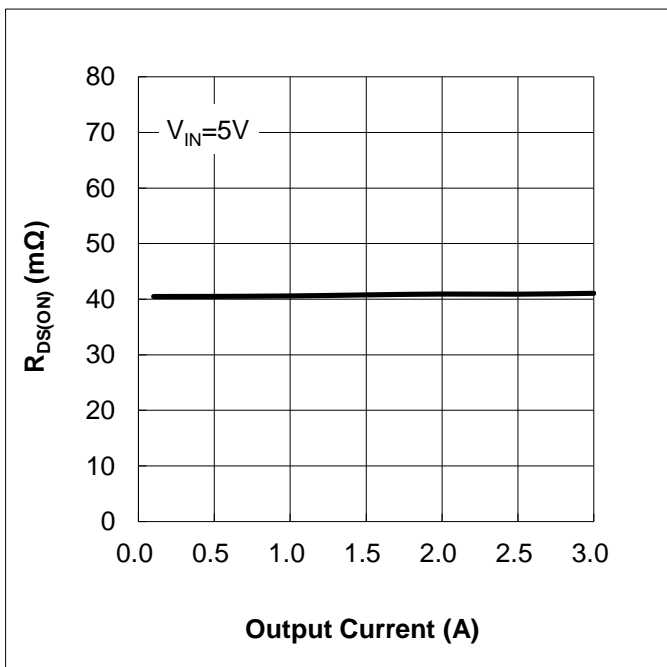
**Input Quiescent Current vs. Temperature**



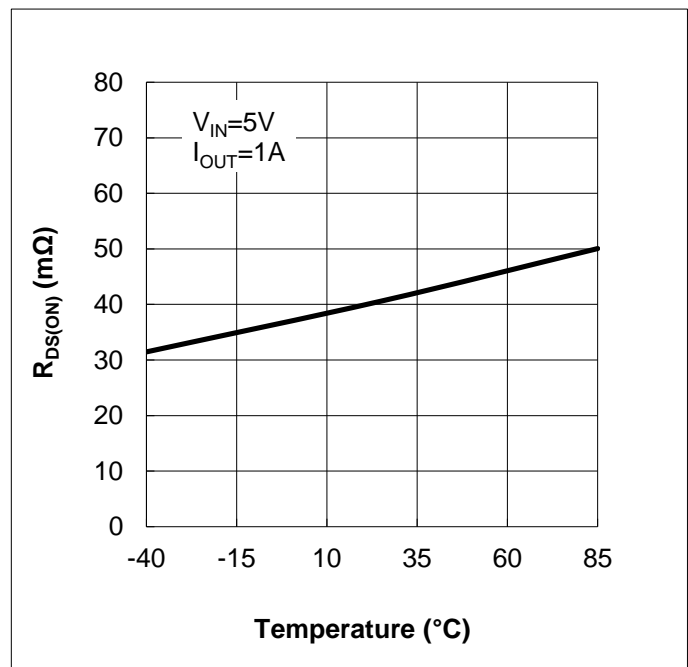
**Input Shutdown Current vs. Temperature**



**$R_{DS(ON)}$  vs. Output Current**



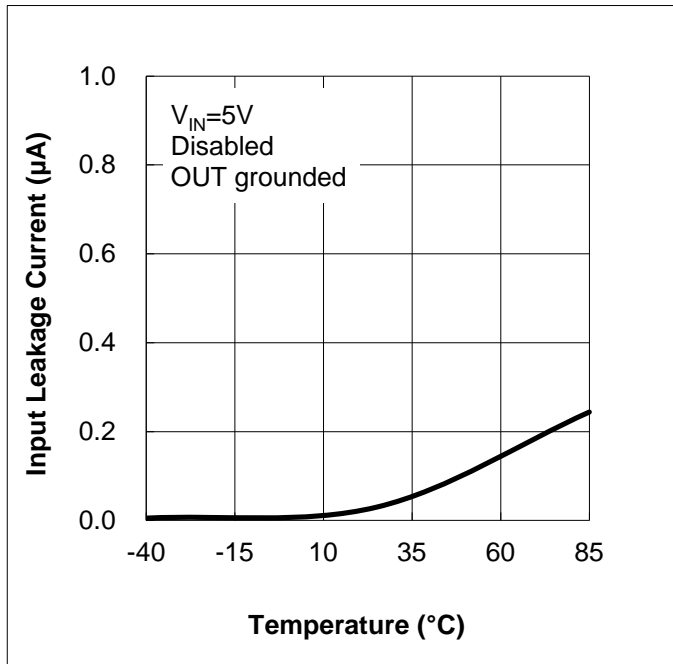
**$R_{DS(ON)}$  vs. Temperature**



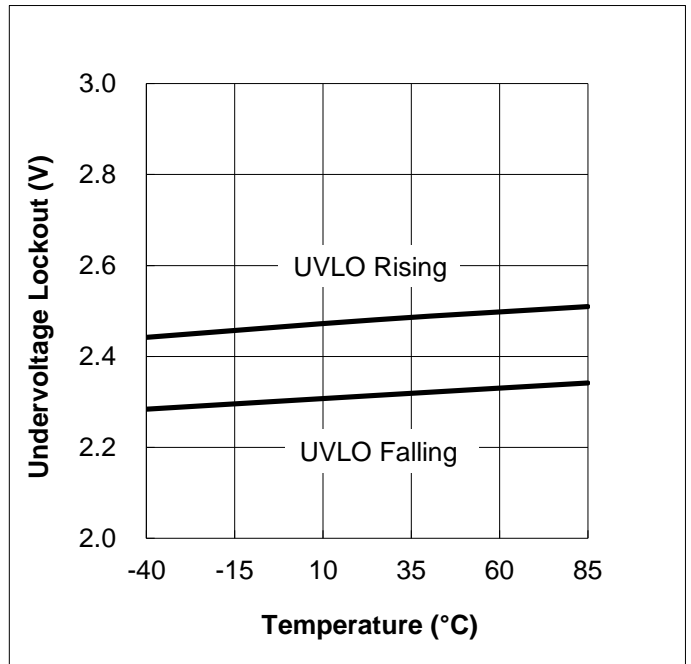


**Typical Performance Characteristics** (continued) ( $T_A = +25^\circ\text{C}$ ,  $V_{IN} = 5\text{V}$ ,  $C_{IN} = 1\mu\text{F}$ ,  $C_L = 0.1\mu\text{F}$ , unless otherwise specified.)

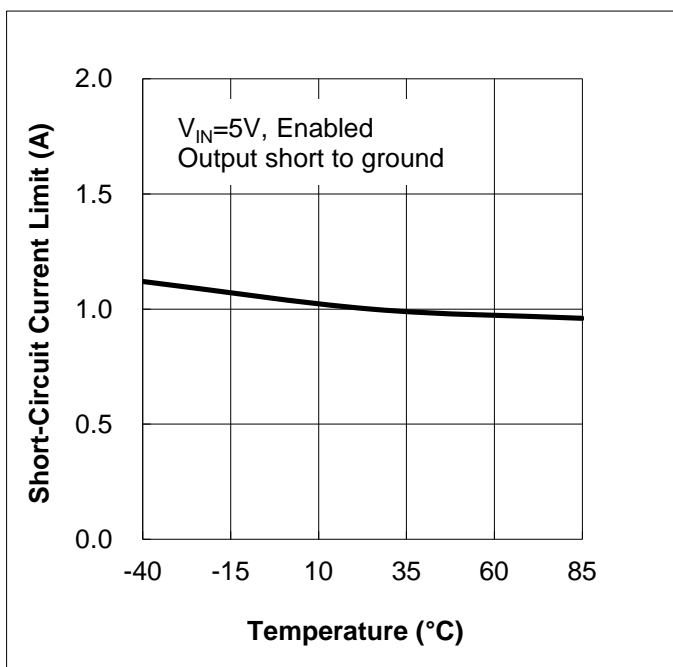
**Input Leakage Current vs. Temperature**



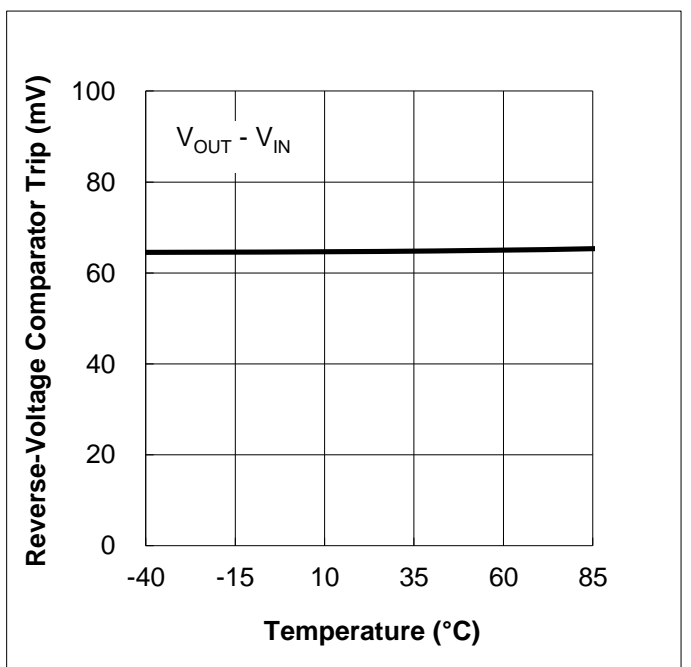
**Under Voltage Lockout vs. Temperature**



**Short-Circuit Output Current vs. Temperature**

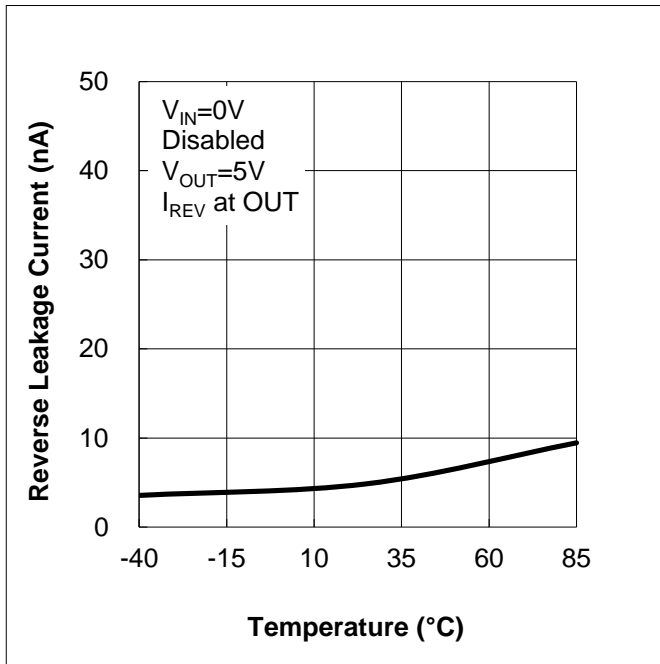


**Reverse-Voltage Comparator Trip vs. Temperature**

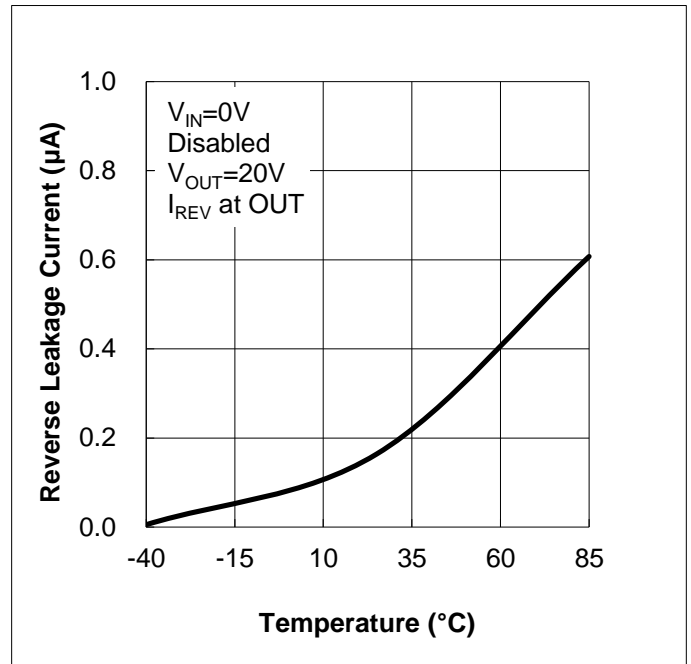


**Typical Performance Characteristics** (continued) ( $T_A = +25^\circ\text{C}$ ,  $V_{IN} = 5\text{V}$ ,  $C_{IN} = 1\mu\text{F}$ ,  $C_L = 0.1\mu\text{F}$ , unless otherwise specified.)

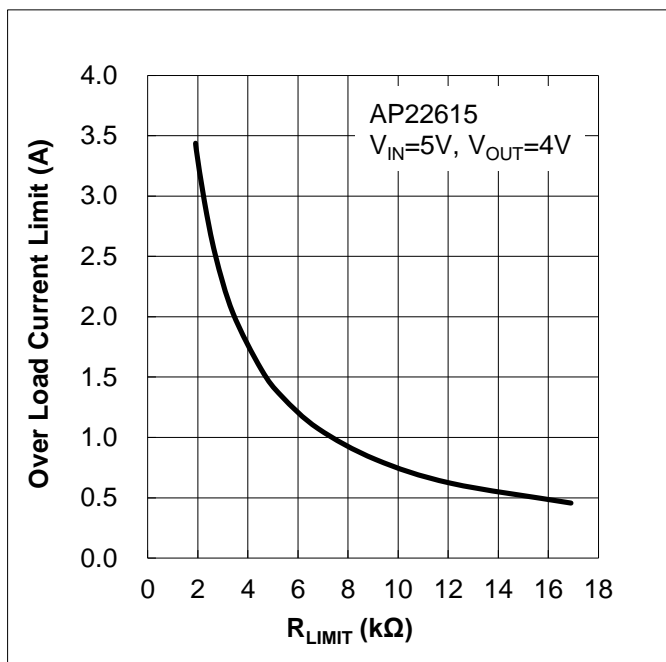
**Reverse Leakage Current vs. Temperature**



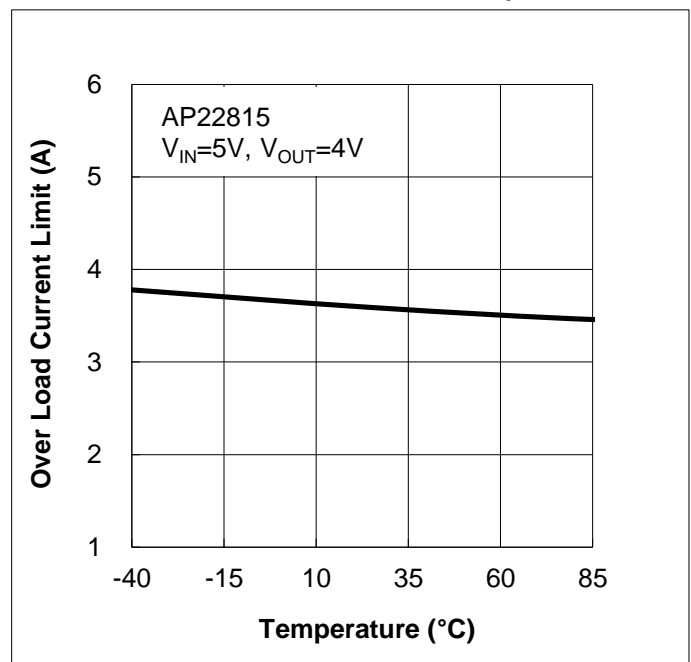
**Reverse Leakage Current vs. Temperature**



**Over Load Current Limit vs.  $R_{LIMIT}$**

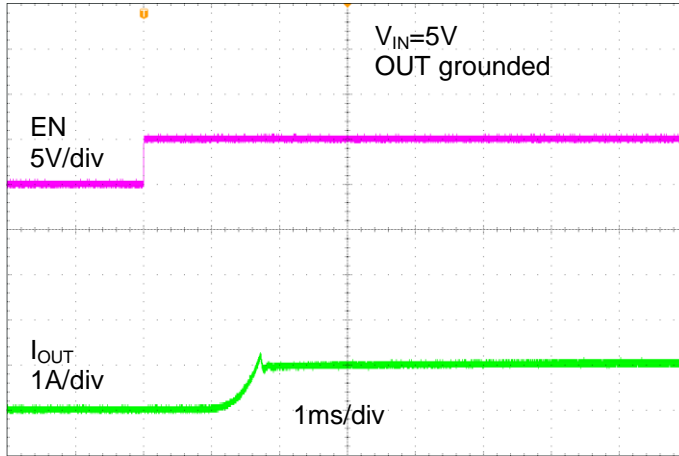


**Over Load Current Limit vs. Temperature**

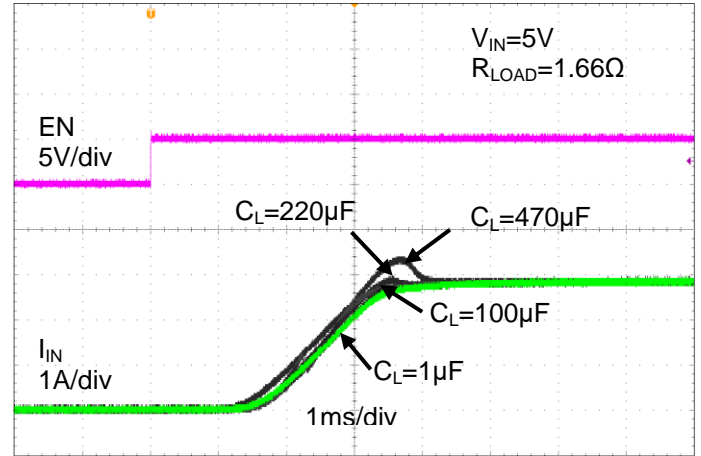


**Typical Performance Characteristics** (continued) ( $T_A = +25^\circ\text{C}$ ,  $V_{IN} = 5\text{V}$ ,  $C_{IN} = 1\mu\text{F}$ ,  $C_L = 0.1\mu\text{F}$ , unless otherwise specified.)

**Device Enabled Into Short-Circuit**



**Inrush Current**



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## Application Information

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### Input and Output Capacitors

It is required to place a 1 $\mu$ F X7R or X5R ceramic bypass capacitor between IN and GND—close to the device. It is recommended to place a high-value capacitor (10 $\mu$ F or 47 $\mu$ F) close to the input pin when the output transient load is heavy. This precaution reduces power-supply transients that can cause ringing on the input.

Connecting a minimum 100 $\mu$ F low ESR electrolytic or tantalum capacitor (or 22 $\mu$ F MLCC) between OUT and GND is also required for hot-plug applications, which is required to bypass the output with a 0.1 $\mu$ F ceramic capacitor that improves the immunity of the device to short-circuit transients. The bulky 100 $\mu$ F or larger capacitors help reduce output droop voltage when a device is plugged in. When abnormal short-circuit condition happens, these capacitors can also reduce output negative voltage due to parasitic inductive effects and avoid device damage.

Note that without the bypass capacitors, an output short can cause ringing on the input. If the voltage is over the maximum voltage rating, it will destroy the internal control circuitry even if the duration is short.

### FLG Response

When an overcurrent, overtemperature, or overvoltage shutdown condition is encountered, the FLG open-drain output goes active low after a nominal 7ms deglitch timeout. The FLG output remains low until overcurrent, overtemperature, or overvoltage conditions are removed. Connecting a heavy capacitive load to the output of the device can cause a momentary overcurrent condition, which does not trigger the FLG due to the 7ms deglitch timeout. The AP22815/AP22615 is designed to eliminate false overcurrent reporting without the need for external components, removing unwanted pulses.

When  $V_{IN}$  operates below 4V, the lower  $V_{IN}$  voltage results in higher equivalent  $R_{ON}$  and can potentially cause the FLG signal to be triggered at a higher output current.

### Overcurrent and Short-Circuit Protection

An internal-sensing FET is employed to check for overcurrent conditions. Unlike current-sense resistors, sense FETs do not increase the series resistance of the current path. When an overcurrent condition is detected, the device maintains a constant output current and reduces the output voltage accordingly. Complete shutdown occurs only if the fault stays long enough to activate thermal limiting.

Three possible overload conditions can occur. In the first condition, the output has been shorted to GND before the device is enabled or before  $V_{IN}$  has been applied. The AP22815/AP22615 senses the short circuit and immediately clamps the output current to a certain safe level.

In the second condition, an output short or overload occurs while the device is enabled. At the instance the overload occurs, higher current can flow for a very short period of time before the current-limit function can react. After the current-limit function has tripped, the device switches into the current-limiting mode, and the current is clamped at  $I_{LIMIT}$  or  $I_{SHORT}$ .

In the third condition, the load is gradually increased beyond the recommended operating current. The current is permitted to rise until the current-limit threshold ( $I_{TRIG}$ ) is reached or until the thermal limit of the device is exceeded. The AP22815/AP22615 is capable of delivering current up to the current-limit threshold without damaging the device. Once the threshold is reached, the device switches into its current-limiting mode and is set at  $I_{LIMIT}$ .

### Thermal Protection

Thermal protection prevents the IC from damage when heavy-overload or short-circuit faults are present for extended periods of time. The AP22815/AP22615 implements thermal sensing to monitor the operating junction temperature of the power distribution switch. Once the die temperature rises to approximately +140°C due to excessive power dissipation in an overcurrent or short-circuit condition the internal thermal sense circuitry turns the power switch off, thus preventing the power switch from damage. Hysteresis is built into the thermal sense circuit, allowing the device to cool down approximately +35°C before the switch turns back on. The switch continues to cycle in this manner until the load fault or input power is removed. The FLG open-drain output is asserted when an overtemperature shutdown or overcurrent occurs with 7ms deglitch.

When  $V_{IN}$  operates below 4V, the lower  $V_{IN}$  voltage results in higher equivalent  $R_{ON}$  and might potentially cause the chip to enter thermal cycling condition by higher output current.

## Application Information (continued)

### ON/OFF Input Operator

The EN input allows the output current to be switched on and off using a GPIO compatible input. The high signal (switch on) must be at least 1.2V and the low signal (switch off) no higher than 0.4V. This pin should *not* be left floating. It is advisable to hold the EN signal low when applying or removing power.

### Undervoltage Lockout (UVLO)

Undervoltage lockout function (UVLO) keeps the internal power switch from being turned on until the power supply has reached at least 2.5V, even if the switch is enabled. Whenever the input voltage falls below approximately 2.3V, the power switch is quickly turned off. This facilitates the design of hot-insertion systems where it is not possible to turn off the power switch before input power is removed.

### Discharge Function

The discharge function of the device is active when enable is disabled or de-asserted. The discharge function with the N-MOS power switch implementation is activated and offers a resistive discharge path for the external storage capacitor. This is designed for discharging any residue of the output voltage when either no external output resistance or load resistance is present at the output.

### Output Reverse-Voltage/Current Protection

The output reverse-voltage protection turns off the MOSFET switch whenever the output voltage is higher than the input voltage by 65mV, and the MOSFET switch turns on when output reverse-voltage conditions are removed. When reverse voltage is lower than 65mV, the reverse current is regulated at approximately 350mA. When the reverse current continuously increases and the reverse voltage is larger than 65mV, the reverse-voltage protection is triggered.

### Fast Role-Swap Function

The AP22615 and AP22815 integrate fast role-swap function, which makes the  $V_{OUT}$  recover to 4.75V within 150 $\mu$ s when the  $V_{OUT}$  drops from high voltage to low. When EN is high,  $V_{IN}$  is valid, and  $V_{OUT}$  is higher than  $V_{IN}$  by 65 mV; the device works at reverse-block mode, and the power FET turns off and stands by for FRS. Once  $V_{OUT}$  drops lower than  $V_{IN}$ , the power FET is turned on in 150 $\mu$ s.

### Power Dissipation and Junction Temperature

The low on-resistance of the internal MOSFET allows the small surface-mount packages to pass large currents. Using the maximum operating ambient temperature ( $T_A$ ) and  $R_{DS(ON)}$ , the power dissipation can be calculated by:

$$P_D = R_{DS(ON)} \times I^2$$

Finally, to calculate the junction temperature:

$$T_J = P_D \times R_{\theta JA} + T_A$$

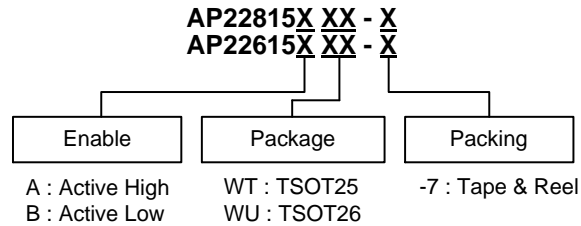
Where:

- $T_A$  = Ambient temperature ( $^{\circ}$ C)
- $R_{\theta JA}$  = Thermal resistance
- $P_D$  = Total power dissipation

### Board Layout Instruction

Placing input and output capacitors, 1 $\mu$ F and 0.1 $\mu$ F+100 $\mu$ F respectively, close and next to the device pins must be implemented to minimize the effects of parasitic inductance. For best performance, all trace lengths must be kept as short as possible. The input and output PCB traces must be as wide as possible. Use a ground plane to enhance the power dissipation capability of the device.

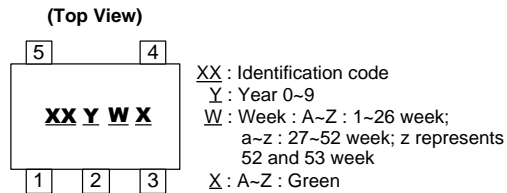
## Ordering Information



Orderable Part Number	Package Code	Package	Packing		
			Quantity	Carrier	Part Number Suffix
AP22815AWT-7	WT	TSOT25	3,000	7" Tape & Reel	-7
AP22815BWT-7	WT	TSOT25	3,000	7" Tape & Reel	-7
AP22615AWU-7	WU	TSOT26	3,000	7" Tape & Reel	-7
AP22615BWU-7	WU	TSOT26	3,000	7" Tape & Reel	-7

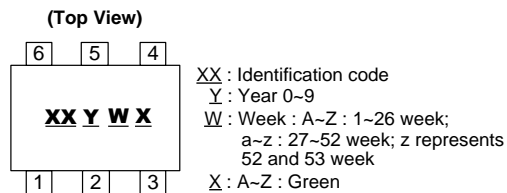
## Marking Information

### (1) TSOT25



Part Number	Package Type	Identification Code
AP22815AWT-7	TSOT25	P5
AP22815BWT-7	TSOT25	P6

### (2) TSOT26

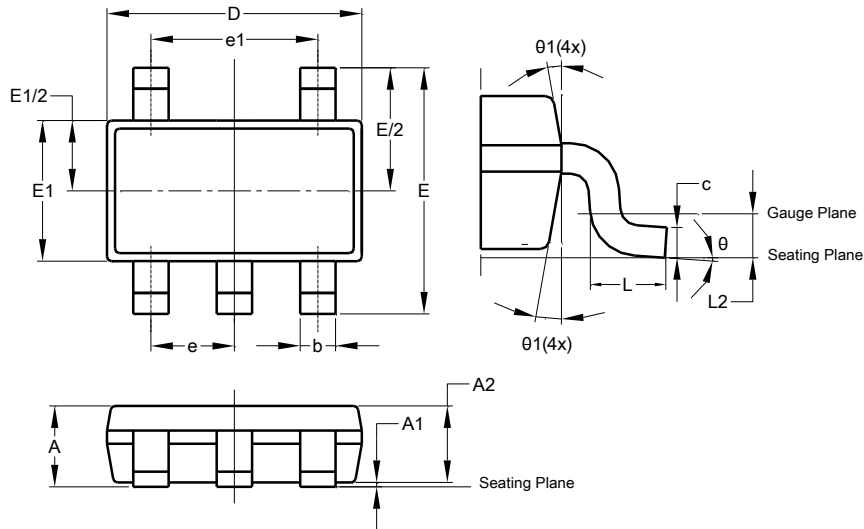


Part Number	Package Type	Identification Code
AP22615AWU-7	TSOT26	P7
AP22615BWU-7	TSOT26	P8

## Package Outline Dimensions

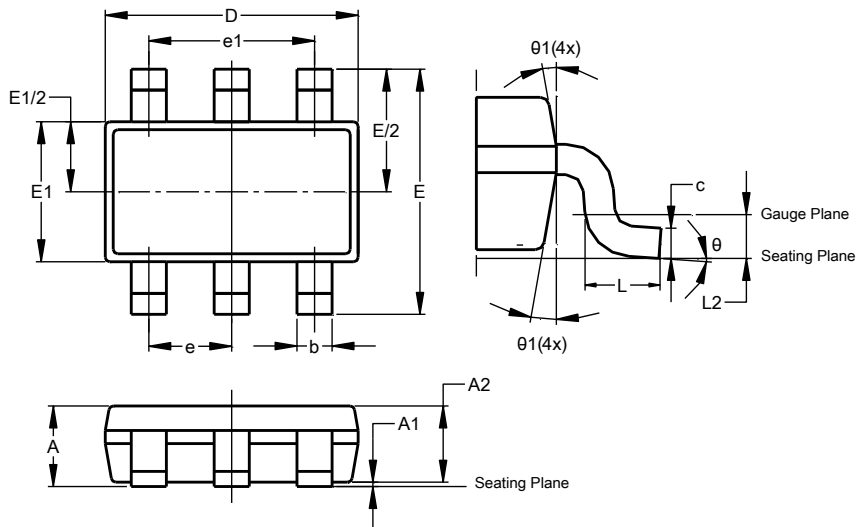
Please see <http://www.diodes.com/package-outlines.html> for the latest version.

### (1) TSOT25



TSOT25			
Dim	Min	Max	Typ
A	-	1.00	-
A1	0.01	0.10	-
A2	0.84	0.90	-
b	0.30	0.45	-
c	0.12	0.20	-
D	-	-	2.90
E	-	-	2.80
E1	-	-	1.60
e	0.95 BSC		
e1	1.90 BSC		
L	0.30	0.50	-
L2	0.25 BSC		
$\theta$	0°	8°	4°
$\theta 1$	4°	12°	-
All Dimensions in mm			

### (2) TSOT26

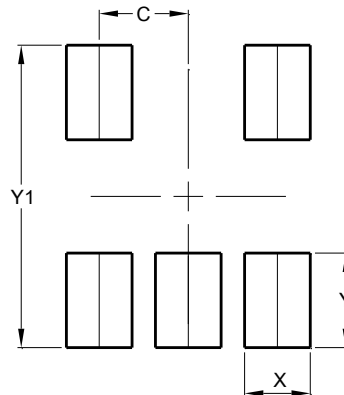


TSOT26			
Dim	Min	Max	Typ
A	-	1.00	-
A1	0.010	0.100	-
A2	0.840	0.900	-
D	2.800	3.000	2.900
E	2.800 BSC		
E1	1.500	1.700	1.600
b	0.300	0.450	-
c	0.120	0.200	-
e	0.950 BSC		
e1	1.900 BSC		
L	0.30	0.50	-
L2	0.250 BSC		
$\theta$	0°	8°	4°
$\theta 1$	4°	12°	-
All Dimensions in mm			

## Suggested Pad Layout

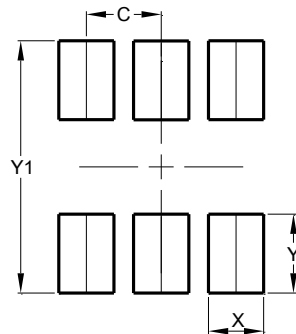
Please see <http://www.diodes.com/package-outlines.html> for the latest version.

### (1) TSOT25



Dimensions	Value (in mm)
C	0.950
X	0.700
Y	1.000
Y1	3.199

### (2) TSOT26



Dimensions	Value (in mm)
C	0.950
X	0.700
Y	1.000
Y1	3.200

## Mechanical Data

- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish – Matte Tin Plated Leads, Solderable per MIL-STD-202, Method 208 (E3)
- Weight: 0.013 grams (Approximate)



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